

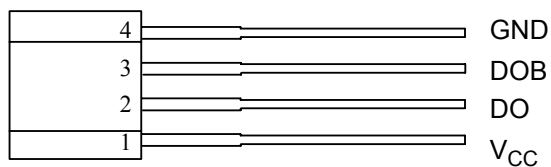
**COMPLEMENTARY OUTPUT HALL EFFECT LATCH****AH277A****Pin Configuration**Z4 Package  
(TO-94)

Figure 2. Pin Configuration of AH277A (Front View)

**Pin Description**

| Pin Number | Pin Name        | Function       |
|------------|-----------------|----------------|
| 1          | V <sub>CC</sub> | Supply voltage |
| 2          | DO              | Output 1       |
| 3          | DOB             | Output 2       |
| 4          | GND             | Ground         |

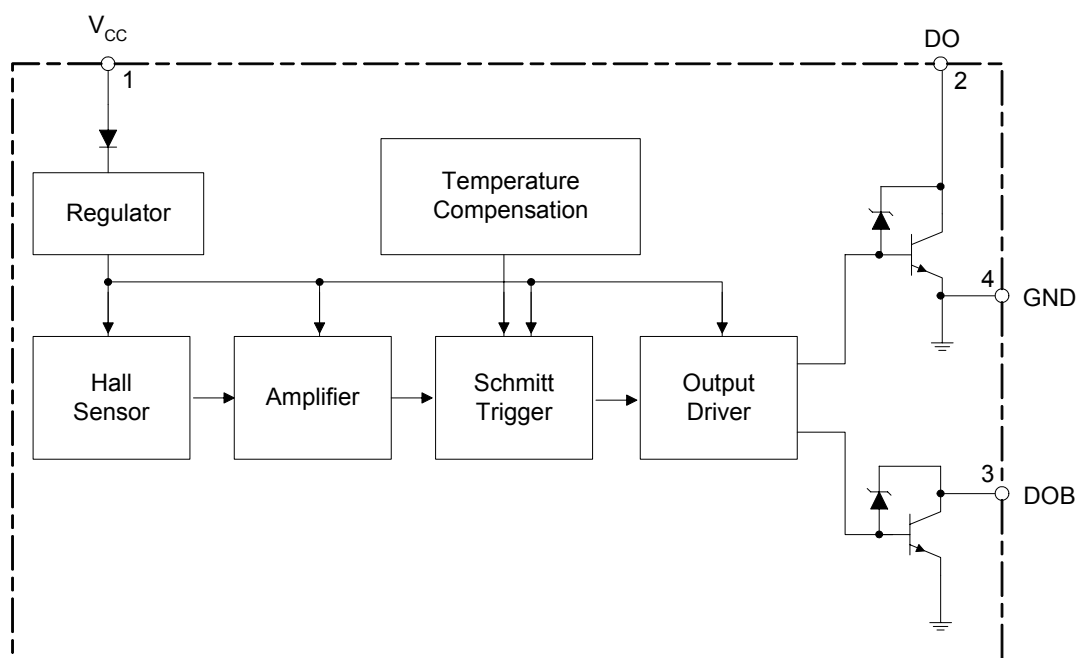
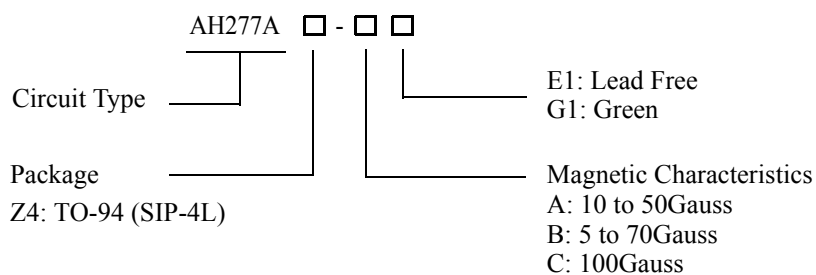
**COMPLEMENTARY OUTPUT HALL EFFECT LATCH****AH277A****Functional Block Diagram**

Figure 3. Functional Block Diagram of AH277A

**Ordering Information**

| Package | Temperature Range | Part Number  |              | Marking ID |           | Packing Type |
|---------|-------------------|--------------|--------------|------------|-----------|--------------|
|         |                   | Lead Free    | Green        | Lead Free  | Green     |              |
| TO-94   | -20 to 85°C       | AH277AZ4-AE1 | AH277AZ4-AG1 | AH277A     | AH277A-G1 | Bulk         |
|         |                   | AH277AZ4-BE1 | AH277AZ4-BG1 | AH277A     | AH277A-G1 | Bulk         |
|         |                   | AH277AZ4-CE1 | AH277AZ4-CG1 | AH277A     | AH277A-G1 | Bulk         |

BCD Semiconductor's Pb-free products, as designated with "E1" suffix in the part number, are RoHS compliant. Products with "G1" suffix are available in green package.

**COMPLEMENTARY OUTPUT HALL EFFECT LATCH****AH277A****Absolute Maximum Ratings (Note 1)**(T<sub>A</sub>=25°C)

| Parameter                  |                     | Symbol           | Value      | Unit  |
|----------------------------|---------------------|------------------|------------|-------|
| Supply Voltage             |                     | V <sub>CC</sub>  | 20         | V     |
| Reverse Protection Voltage |                     | V <sub>RCC</sub> | -20        | V     |
| Magnetic Flux Density      |                     | B                | Unlimited  | Gauss |
| Output Current             | Continuous          | I <sub>O</sub>   | 400        | mA    |
|                            | Hold                |                  | 600        | mA    |
|                            | Peak (start up)     |                  | 800        | mA    |
| Power Dissipation          |                     | P <sub>D</sub>   | 550        | mW    |
| Thermal Resistance         | Die to atmosphere   | θ <sub>JA</sub>  | 227        | °C/W  |
|                            | Die to package case | θ <sub>JC</sub>  | 49         | °C/W  |
| Storage Temperature        |                     | T <sub>STG</sub> | -50 to 150 | °C    |
| ESD (Machine Model)        |                     |                  | 300        | V     |
| ESD (Human Body Model)     |                     |                  | 2000       | V     |

Note 1: Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "Recommended Operating Conditions" is not implied. "Absolute Maximum Ratings" for extended period may affect device reliability.

**Recommended Operating Conditions**(T<sub>A</sub>=25°C)

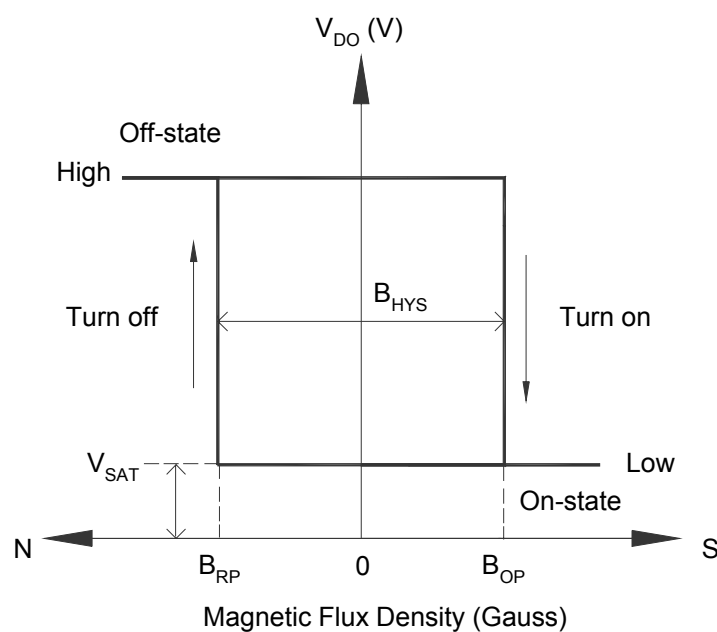
| Parameter           | Symbol          | Min | Max | Unit |
|---------------------|-----------------|-----|-----|------|
| Supply Voltage      | V <sub>CC</sub> | 3.5 | 16  | V    |
| Ambient Temperature | T <sub>A</sub>  | -20 | 85  | °C   |

**COMPLEMENTARY OUTPUT HALL EFFECT LATCH****AH277A****Electrical Characteristics** $(T_A=25^{\circ}\text{C}, V_{CC}=14\text{V}, \text{ unless otherwise specified})$ 

| Parameter                      | Symbol     | Test Condition                           | Min | Typ  | Max | Unit          |
|--------------------------------|------------|------------------------------------------|-----|------|-----|---------------|
| Output Saturation Voltage      | $V_{SAT}$  | $V_{CC}=3.5\text{V}, I_O=100\text{mA}$   |     | 0.4  |     | V             |
|                                |            | $I_O=400\text{mA}$                       |     | 0.35 | 0.6 | V             |
| Output Leakage Current         | $I_{OL}$   | $V_{CE}=16\text{V}$                      |     | 0.1  | 10  | $\mu\text{A}$ |
| Supply Current                 | $I_{CC}$   | $V_{CC}=16\text{V}, \text{ Output Open}$ |     | 12   | 16  | mA            |
| Output Rise Time               | $t_r$      | $R_L=820\Omega, C_L=20\text{pF}$         |     | 3.0  | 10  | $\mu\text{s}$ |
| Output Fall Time               | $t_f$      | $R_L=820\Omega, C_L=20\text{pF}$         |     | 0.3  | 1.5 | $\mu\text{s}$ |
| Switch Time Differential       | $\Delta t$ | $R_L=820\Omega, C_L=20\text{pF}$         |     | 3.0  | 10  | $\mu\text{s}$ |
| Output Zener Breakdown Voltage | $V_Z$      |                                          |     | 55   |     | V             |

**Magnetic Characteristics** $(T_A=25^{\circ}\text{C})$ 

| Parameter       | Symbol    | Grade | Min  | Typ | Max | Unit  |
|-----------------|-----------|-------|------|-----|-----|-------|
| Operating Point | $B_{OP}$  | A     | 10   | 30  | 50  | Gauss |
|                 |           | B     | 5    |     | 70  | Gauss |
|                 |           | C     |      |     | 100 | Gauss |
| Releasing Point | $B_{RP}$  | A     | -50  | -30 | -10 | Gauss |
|                 |           | B     | -70  |     | -5  | Gauss |
|                 |           | C     | -100 |     |     | Gauss |
| Hysteresis      | $B_{HYS}$ |       |      | 60  |     | Gauss |



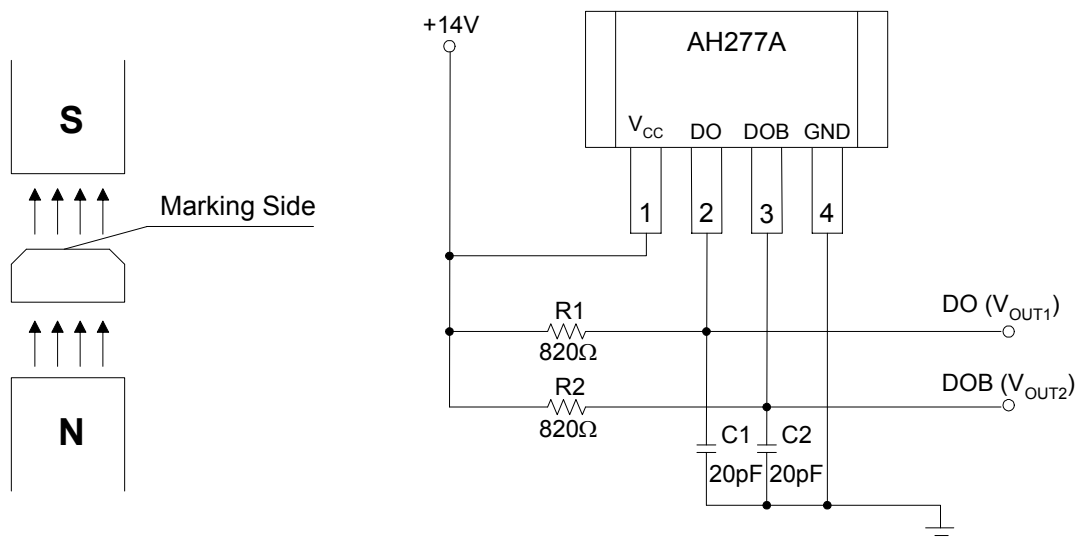
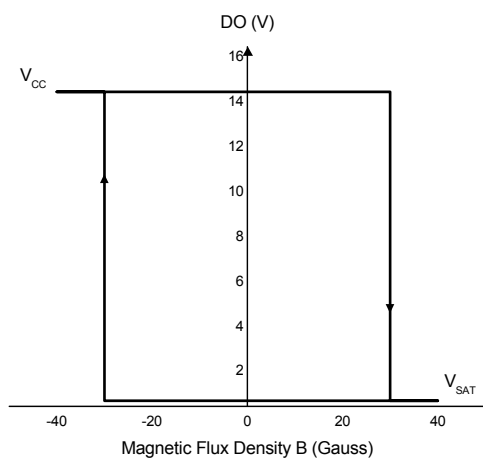
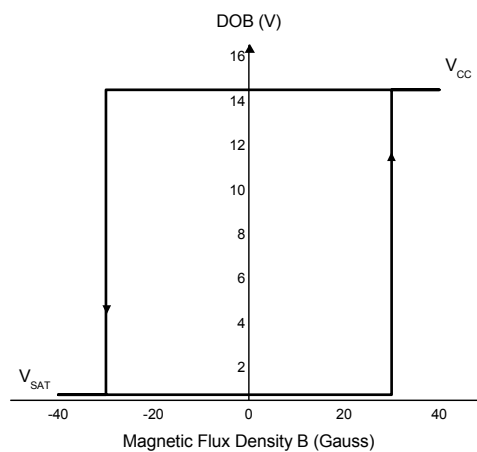
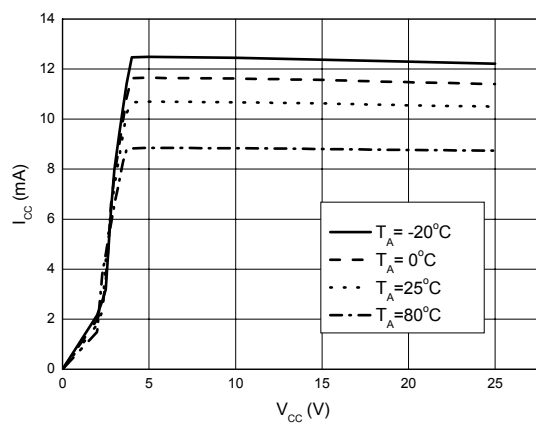
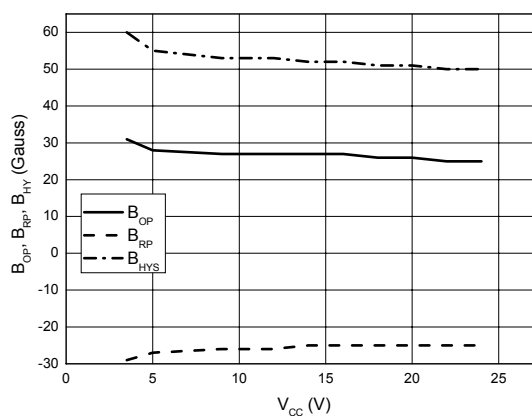
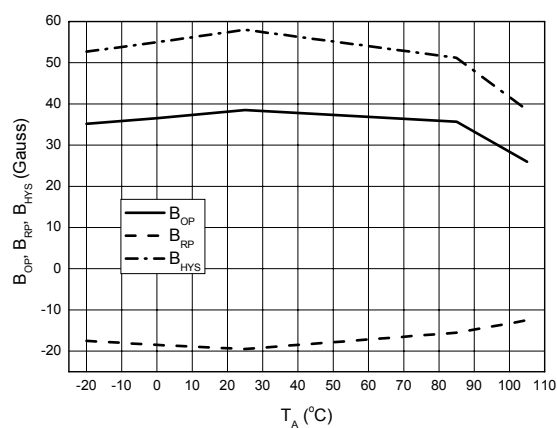
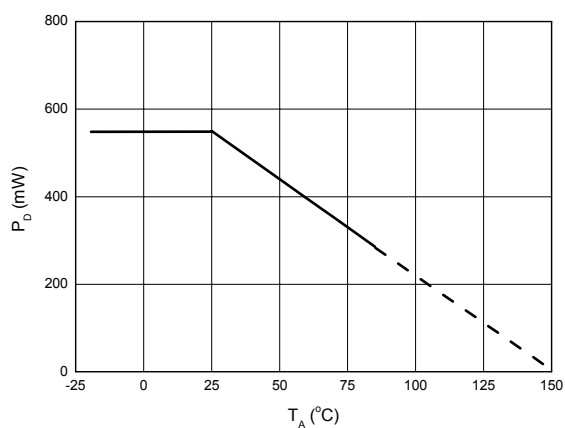
**COMPLEMENTARY OUTPUT HALL EFFECT LATCH**
**AH277A**
**Magnetic Characteristics (Continued)**


Figure 4. Basic Test Circuit


Figure 5.  $V_{DO}$  vs. Magnetic Flux Density

Figure 6.  $V_{DOB}$  vs. Magnetic Flux Density

**COMPLEMENTARY OUTPUT HALL EFFECT LATCH****AH277A****Typical Performance Characteristics**Figure 7. I<sub>CC</sub> vs. V<sub>CC</sub>Figure 8. B<sub>OP</sub>/B<sub>RP</sub>/B<sub>HYS</sub> vs. V<sub>CC</sub>Figure 9. B<sub>OP</sub>/B<sub>RP</sub>/B<sub>HYS</sub> vs. Ambient TemperatureFigure 10. P<sub>D</sub> vs. Ambient Temperature

# COMPLEMENTARY OUTPUT HALL EFFECT LATCH

AH277A

## Typical Performance Characteristics (Continued)

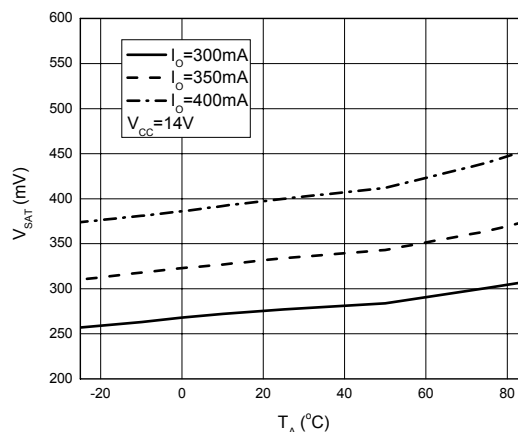
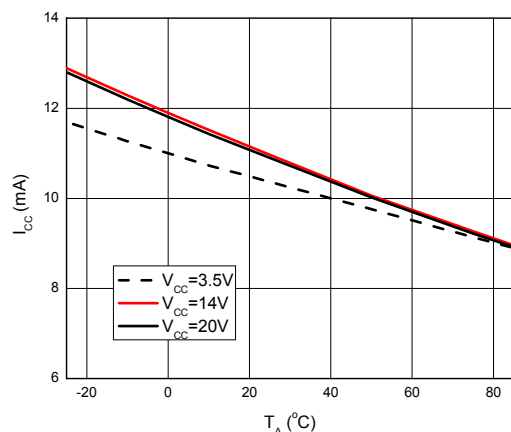


Figure 11. Supply Current vs. Ambient Temperature

Figure 12. Saturation Voltage vs. Ambient Temperature

## Typical Applications

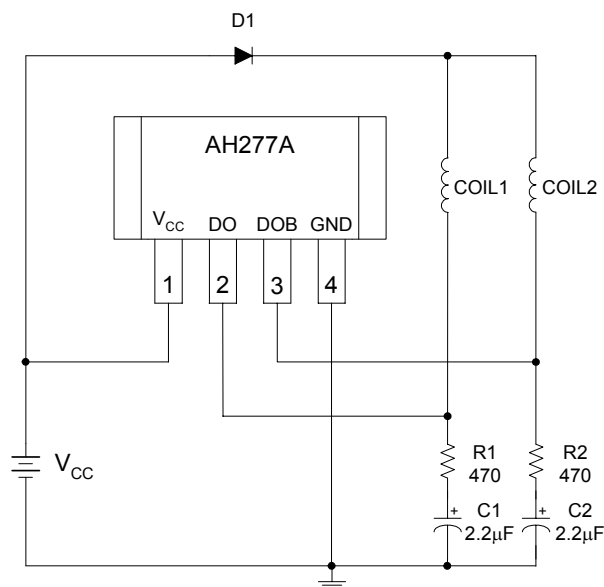
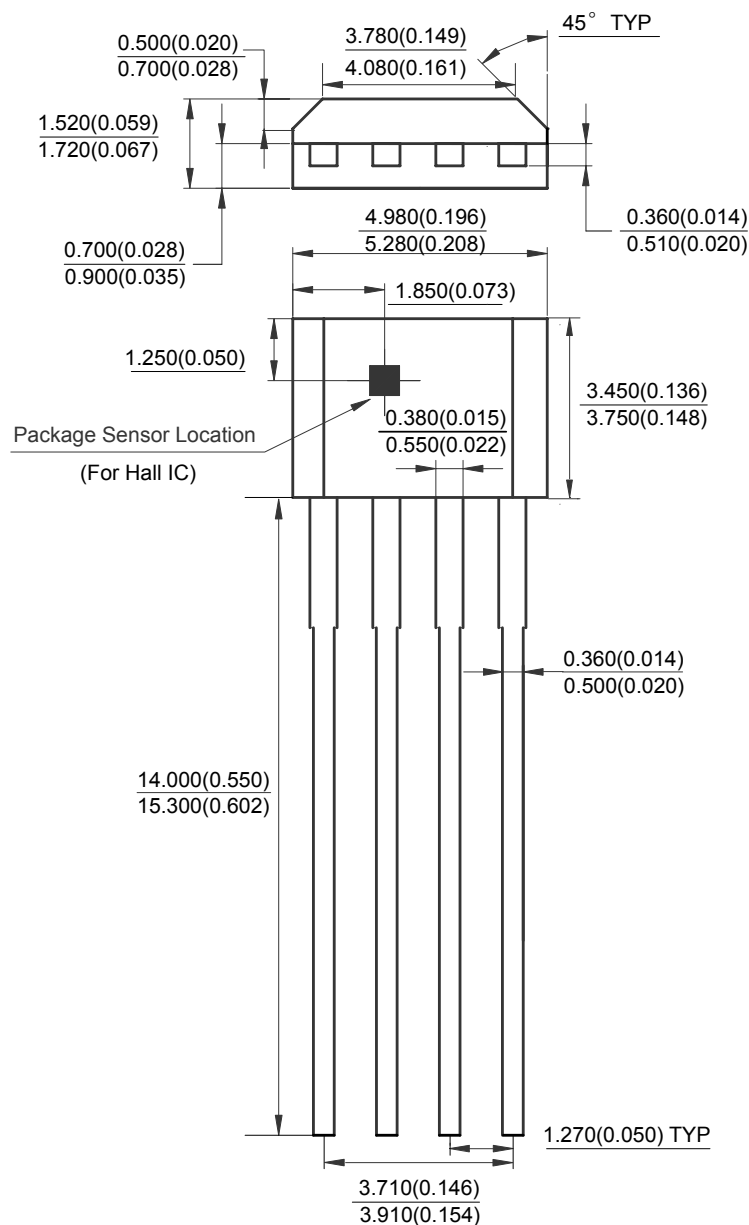


Figure 13. Typical Application Circuit with D1(Note 2)

Note 2: AH277A has Reversed Supply Voltage Protection. For DC fan application, sometimes need to test power reverse connection condition. The internal diode only protects chip-side but not for coil-side. It is recommended to add one external diode D1 in application to block the reverse current from coil-side as shown in Figure 13.

**COMPLEMENTARY OUTPUT HALL EFFECT LATCH****AH277A****Mechanical Dimensions****TO-94****Unit: mm(inch)**



## **BCD Semiconductor Manufacturing Limited**

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